

# Phenomenological BRDF Modeling For Engineering Applications

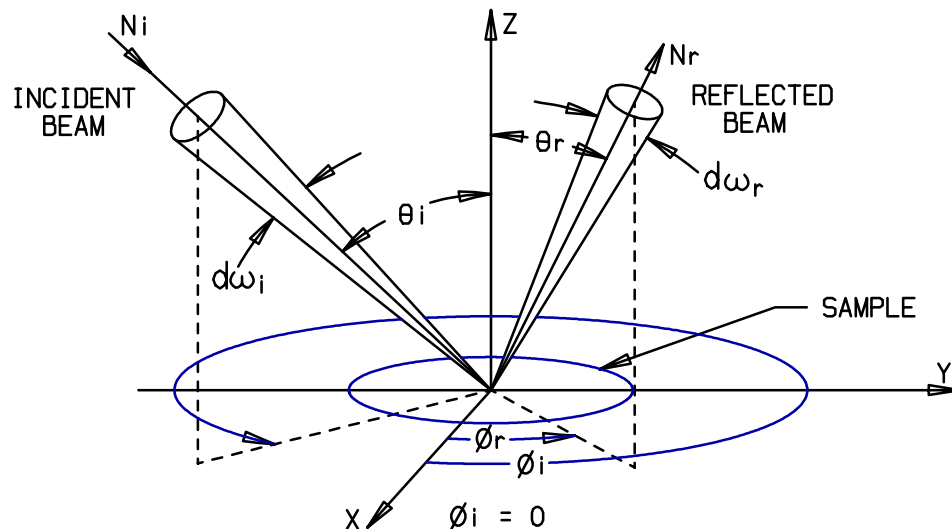


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# Outline

- BRDF Definition
- Optical Measurements
- Optical Properties of Materials
- Phenomenological BRDF Modeling
- Parameterized BRDF Models
- Conclusions

# Bidirectional Reflectance Distribution Function (BRDF)



**BRDF:**  $\rho'(\theta_i, \theta_r, \phi)$

$$\frac{\delta N_r(\theta_r, \phi)}{N_i(\theta_i)} = \rho'(\theta_i, \theta_r, \phi) \cos \theta_i \delta \Omega_i$$

**DHR:**  $\rho_D(\theta_i)$

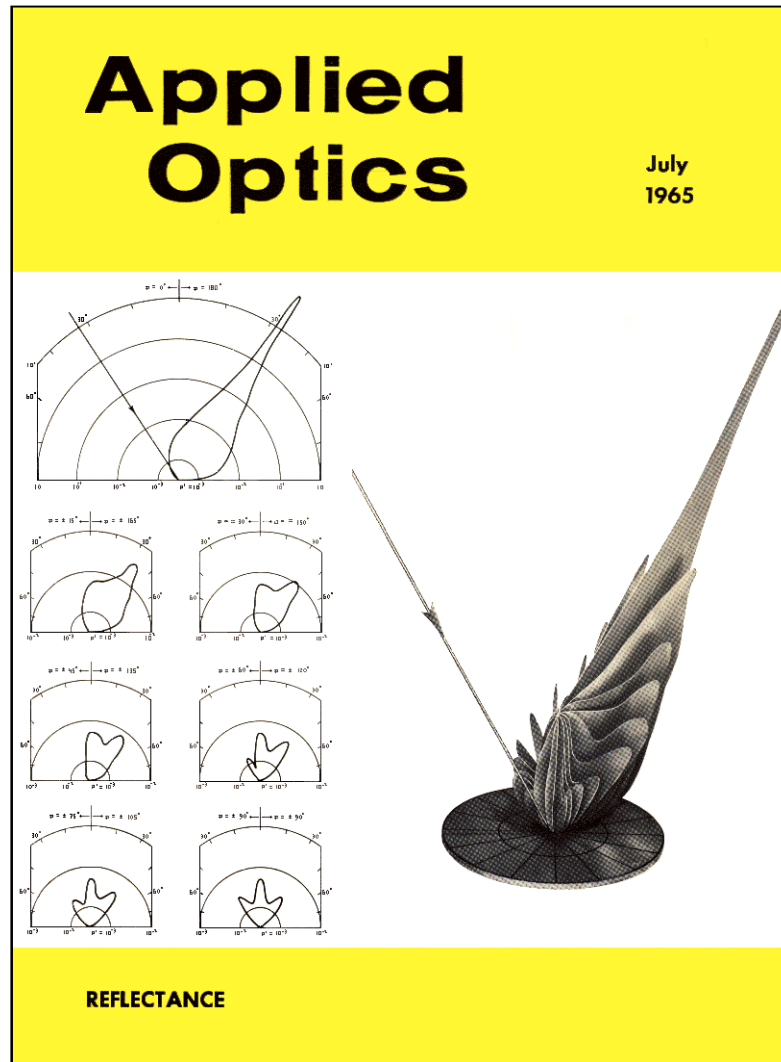
$$\begin{aligned} \frac{N_r}{N_i(\theta_i)} &= \iint \rho'(\theta_i, \theta_r, \phi) \cos \theta_r \sin \theta_r d\theta_r \\ &= \rho_D(\theta_i) \end{aligned}$$

- $\hat{n}$  = Outward Surface Normal Unit Vector
- $\theta_i$  = Incident Zenith Angle
- $\theta_r$  = Reflected Zenith Angle
- $\phi$  = Reflected Azimuth Angle

(These apply to isotropic surfaces; also,  
 $\phi \equiv \phi_r - \phi_i$  here.)

$\pi \rho' = \rho_D$  For Lambertian Diffuse Surface

# Pictorial Representation of BRDF



F. Nicodemus,  
“Directional Reflectance  
and Emissivity of an  
Opaque Surface”,  
*Appl. Opt.*, **4**, 767-773,  
1965.

# Optical Instrumentation for Coatings Characterization

## **SOC-600 Hand-Held Directional Reflectometer (HHDR)**



Measures BRDF of A Sample at Over 30,000 Reflectance Angles  
Varying Incidence Angle from 0° to 85°  
Currently 3-5  $\mu\text{m}$  and 8-12  $\mu\text{m}$  Bands  
Visible/Spectral IR Heads in Development  
Computes HDR from BRDF  
Displays Real Time Images of BRDF  
Providing a Pass/Fail Indication for HDR & BRDF  
Frame Rates Up To 60 Per-Second

## **SOC-400 Surface Measurement System**

Handheld FTIR for Lab/Field Spectroscopic Analysis

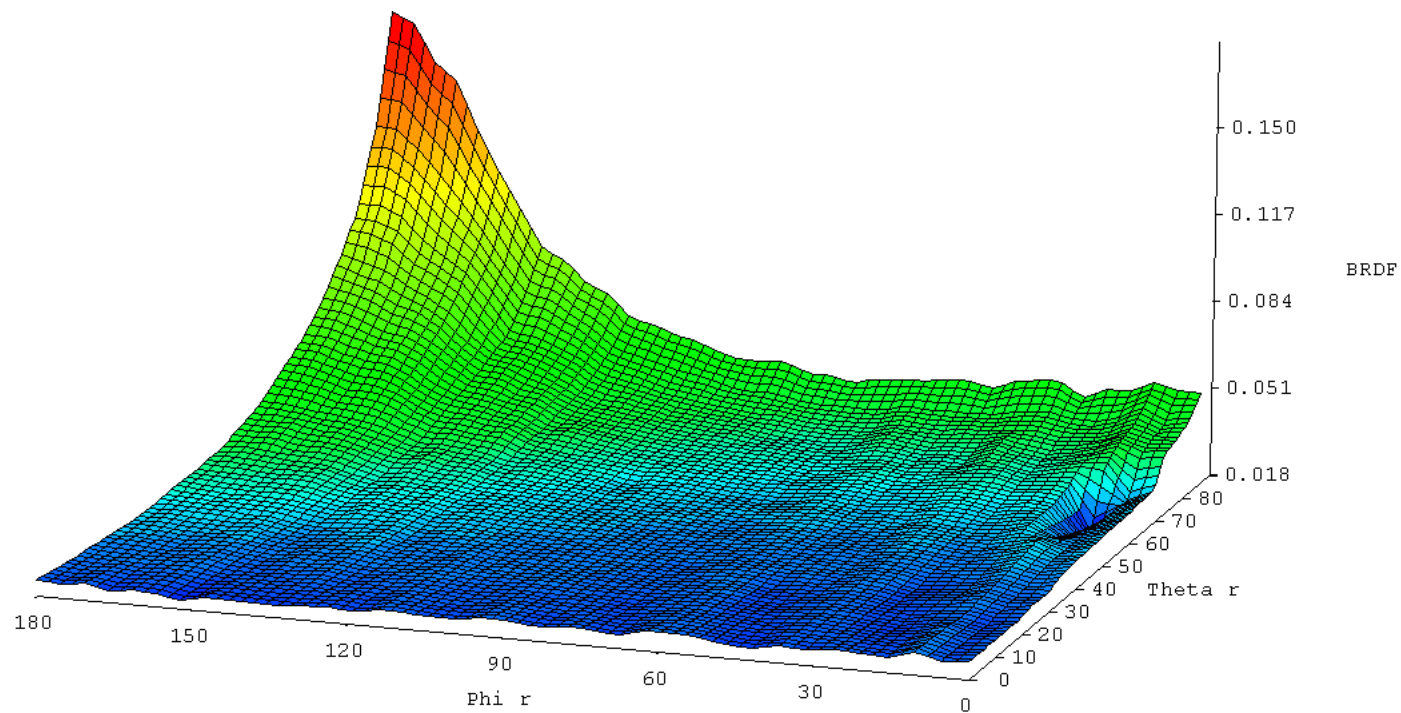
Optical Heads for Specular, Diffuse and Hemispheric Measurements  
Spectral Coverage from 2-25  $\mu\text{m}$ , 2,4,8,16,32  $\text{cm}^{-1}$  Resolution  
Longneck Accessory for Remote Sampling and Visualization  
Accessories for Non-KBr analysis of Powders  
Diffuse Head for Surface Inspection of Contaminants and Films  
Robotic Control for Matrix Mapping of Surfaces



# BRDF Measurements

Army Green 383 Camouflage Paint

$\lambda = 0.5$  microns  $\theta_i = 50^\circ$



# Reflection and Transmission from a Plane Medium

- Fresnel Coefficients for Oblique Incidence

$$r_l = \frac{E_{lr}}{E_{li}} = \frac{\cos \Theta_t - m \cos \Theta_i}{\cos \Theta_t + m \cos \Theta_i} \quad \text{Parallel} \quad t_l = \frac{E_{lt}}{E_{li}} = \frac{2 \cos \Theta_i}{\cos \Theta_t + m \cos \Theta_i}$$

$$r_r = \frac{E_{rr}}{E_{ri}} = \frac{\cos \Theta_i - m \cos \Theta_t}{\cos \Theta_i + m \cos \Theta_t} \quad \text{Perpendicular} \quad t_r = \frac{E_{rt}}{E_{ri}} = \frac{2 \cos \Theta_i}{\cos \Theta_i + m \cos \Theta_t}$$

Where:  $m \sin \Theta_t = \sin \Theta_i$  (Snell's Law)  
 $m = (n - ik)$  Complex Refractive Index

Unpolarized Reflection and Transmission:

$$R(\Theta_i) = \frac{1}{2} (|r_l|^2 + |r_r|^2) \quad \text{and} \quad T(\Theta_i) = \frac{1}{2} (|t_l|^2 + |t_r|^2)$$

# Absorption in a Medium

- EM Poynting Vector for Complex Refractive Index  
 $m = (n + ik)$

$$S = \frac{1}{2} \operatorname{Re} \left\{ \sqrt{\frac{\epsilon}{\mu}} \right\} |E_o|^2 \exp\left(-\frac{4\pi k}{\lambda}\right) \hat{e}$$

- Irradiance,  $I$  [*energy/area/time*], is magnitude of  $S$
- Energy absorbed in medium over path,  $z$ , is

$$I = I_o e^{-\alpha z}$$

- The Absorption coefficient is defined as

$$\alpha = \frac{4\pi k}{\lambda}$$



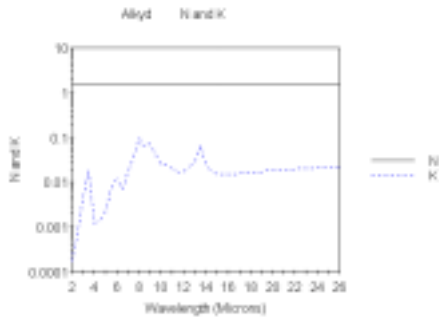
# Optical Theory of Materials

- Frequency Inter-Dependence of the Real and Imaginary parts is given by the Kramers-Kronig (Dispersion) Relations

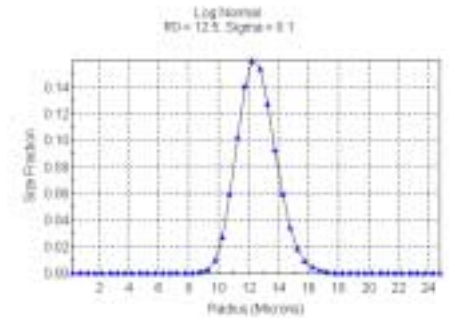
$$\varepsilon'(\omega) = 1 + \frac{2}{\pi} \int_0^{\infty} \frac{\Omega \varepsilon''(\Omega)}{\Omega^2 - \omega^2} d\Omega$$

- Phenomenological Models Used to Describe Frequency Dependence
  - Lorentz Model for Damped Electronic, Molecular and Lattice Vibrations
  - Debye Model for Molecular Polarizability
  - Drude Model for Free Electrons in Metals

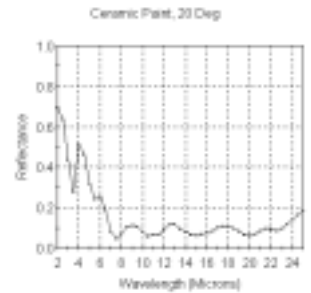
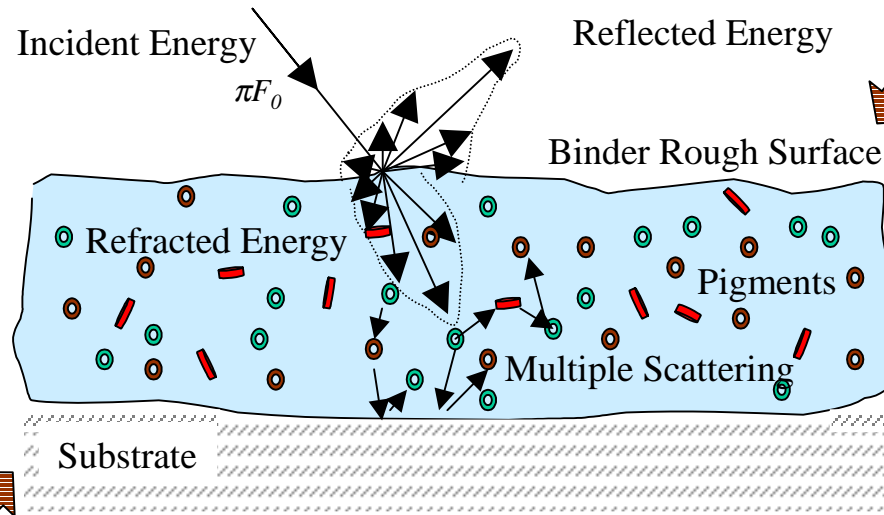
# Optical Phenomenology of Composite Materials



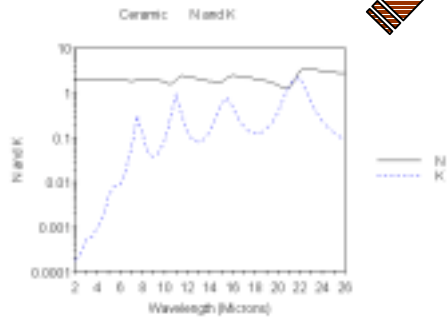
Binder Optical Constants



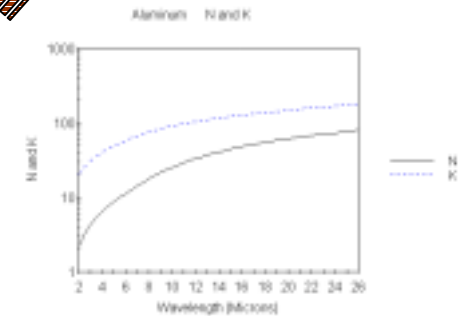
Pigment Size Distribution



Spectral Reflectance



Pigment Optical Constants



Substrate Optical Constants

# Analytical Techniques

- Mie/Non-Spherical Techniques for Calculating Pigment Single Scattering
- Multiple Scattering Radiative Transfer Used for Volume Scattering
- Rough Surface Scattering Used for Binder Interface
- Radiative Coupling of Surface and Volume Scattering

# Scattering Coatings Computer Aided Design (ScatCad) Code

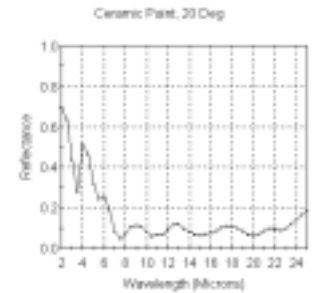
- Implements Single Scattering and Multiple Scattering Radiative Transfer Techniques for Engineering Analysis of Pigmented Coatings
- Predicts the Spectral BRDF and HDR Based on the Optical Constants and Micro-Physical Composition of the Coating
- Windows 95/98/NT PC Based
- Provides Modules for Optical Constant Analysis
- Interfaces to SOC-200/600 BDR and SOC-100/400 HDR Measurement Systems

# Analysis Based Coatings Design

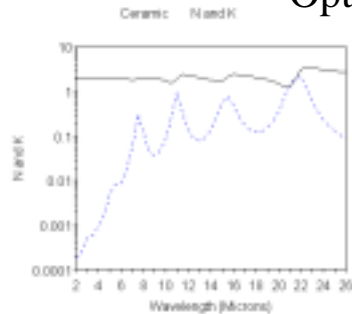


Optical Characterization  
of Materials

ScatCad Analysis

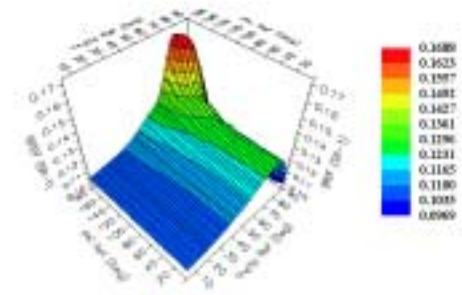
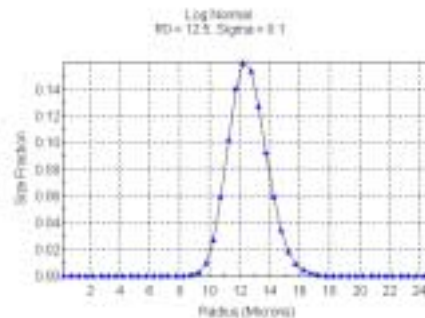
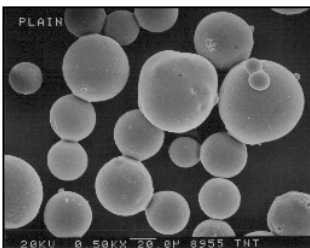


Optical Constants



Spectral Directional  
and Bidirectional  
Reflectance

Physical Characterization of Materials



# Pigment Single Scattering

- Mie Theory for Homogeneous and Layered Spherical Pigments
  - 20 Layer Sphere Algorithm Developed by Weisbrod (MDTI-TM-92-01, McDonnell Douglas, 1992)
- Non-Spherical Single Scattering Techniques
  - Henyey-Greenstein, 2 Parameter Phase Function
  - T-Matrix for Axially Symmetric Particles (Mishchenko, *Appl. Opt.*, **32**, 4652-4666, 1993)
  - Discrete Dipole Approximation for Non-Homogeneous/Irregular Particles (Draine and Flatau, *J. Opt. Soc. Am.*, **11**, 1491-1499, 1994)

# Radiative Transfer Analysis

## Radiative Transfer Equation

$$\mu \frac{dI(\theta, \phi)}{d\tau} = -I(\theta, \phi) + \frac{\omega_0}{4\pi} \int_{4\pi} p(\theta', \phi', \theta, \phi) I(\theta', \phi') d\omega' \\ + \frac{\omega_0}{4} p(\theta_0, \phi_0, \theta, \phi) F_o e^{-\tau/\mu_0} + (1 - \omega_0) B(T).$$

Where

$\omega_0$  is the single scattering albedo

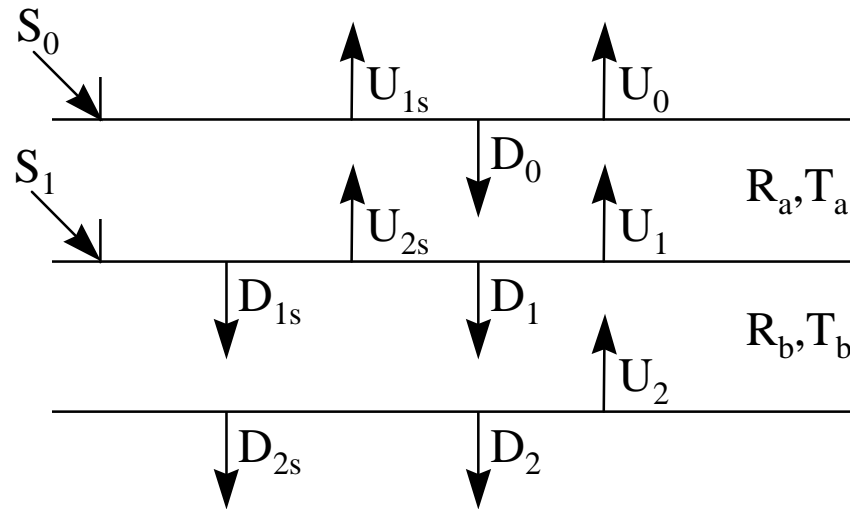
$p(\theta', \phi', \theta, \phi) = p(\cos \alpha)$  is the phase function

$F_o$  is the incident source radiation

$B(T)$  is the thermal emission

$\mu = \cos \theta$

# HDR Analysis



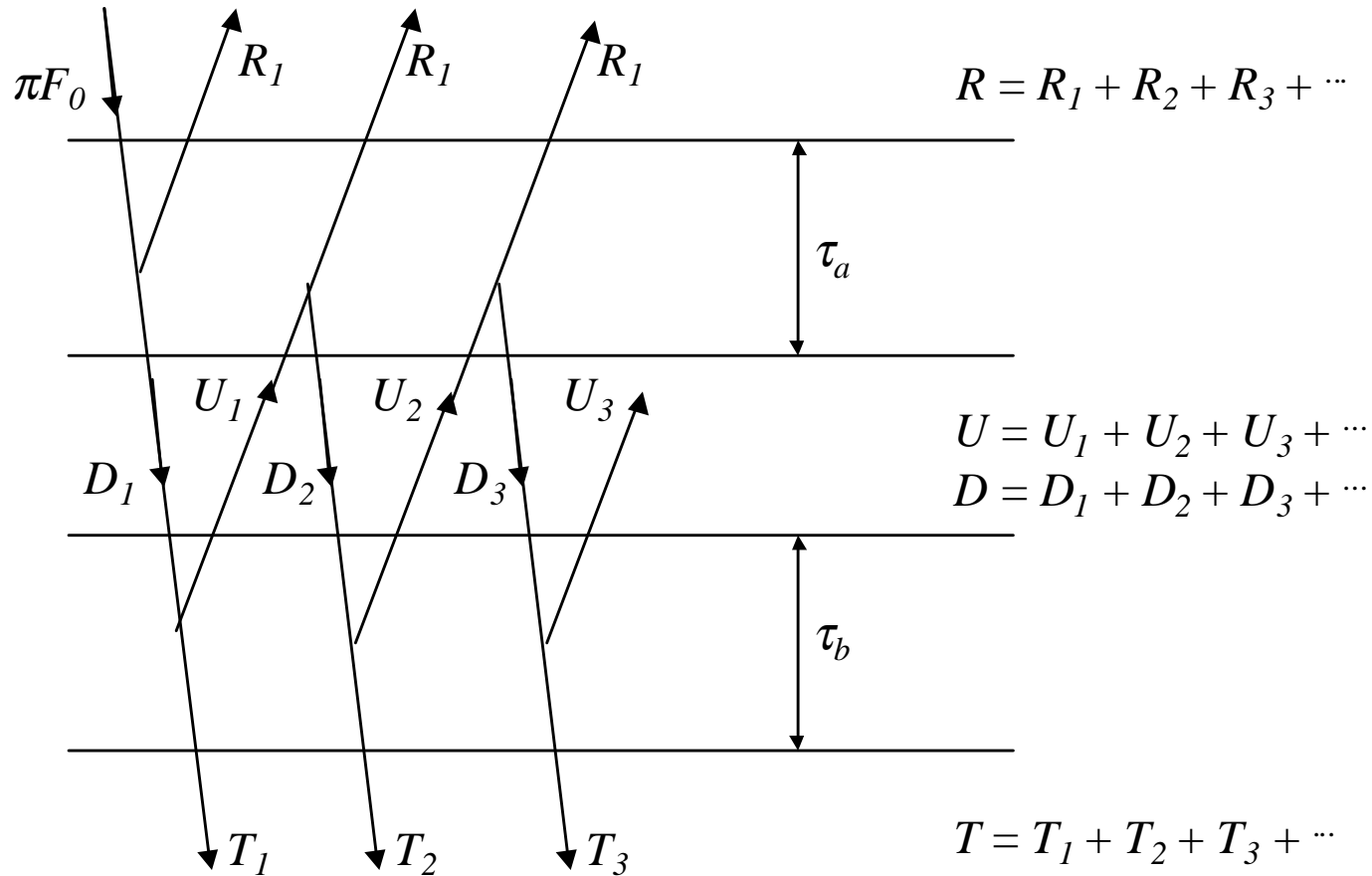
- Extension of Kubelka-Munk Two-Flux Analysis
- Uses Three-Flux Approximation to Radiative Transfer Equation
  - Provides Rapid Spectral Calculations for Design Optimization
- Considers Multiple Paint Layers Over Substrate
  - Surface Scattering Not Included
- Binder Absorption Treated as Additional Pigment Absorption

$$\text{mean free path} = l_m = 1/(N\pi r^2)$$

$$\Delta C_{abs} = 4\pi l_m k_b / \lambda$$



# BRDF Analysis - Adding/Doubling



# Adding/Doubling Technique

Radiative Adding of Two Layers,  $\tau_a$  and  $\tau_b$

$$S = R_a * R_b [I - R_a * R_b]^{-1}$$

$$D = T_a * S \exp(-\tau_a / \mu_o) + S * T_a$$

$$U = R_b \exp(-\tau_a / \mu_o) + R_b * D$$

$$R(\tau_a + \tau_b) = R_a + \exp(-\tau_a / \mu_o) U + T_a * U$$

$$T(\tau_a + \tau_b) = \exp(-\tau_b / \mu_o) D + T_b \exp(-\tau_a / \mu_o) + T_b * D$$

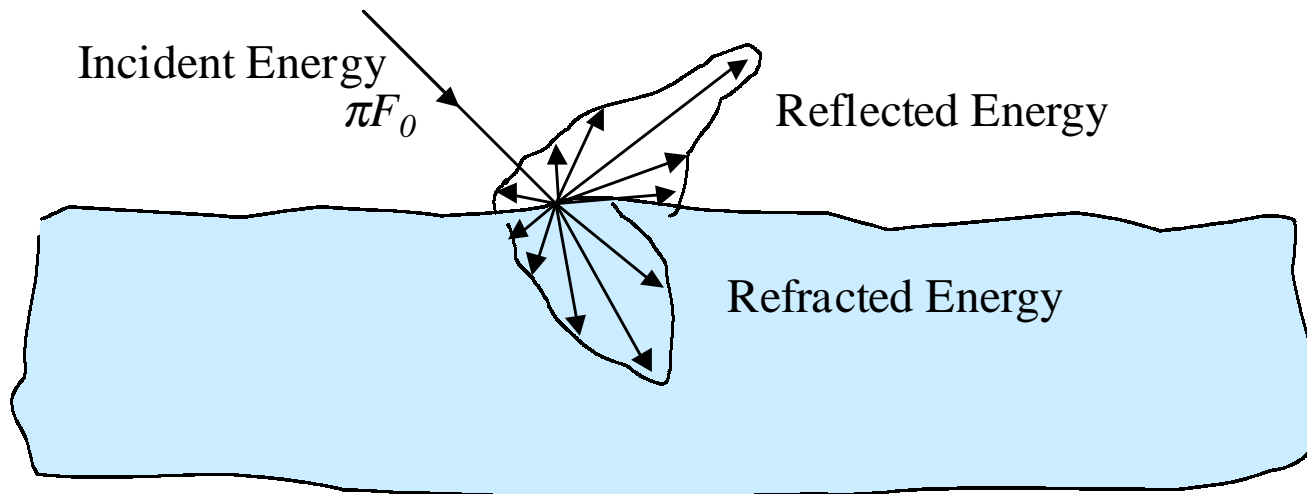
Where  $X * Y$  terms represent integrals over zenith angle

$$X * Y = \int_0^1 x^m(\mu, \mu') y^m(\mu', \mu_o) 2\mu' d\mu'$$

And  $x^m$  is the Fourier expansion in azimuth

$$x^m(\mu, \mu_o) = \frac{1}{2\pi} \int_0^{2\pi} x(\mu, \mu_o, \phi) \cos m\phi d\phi$$

# Rough Surface Scattering



## Slightly Rough Surfaces

- Rice perturbation model
- Roughness is isotropic
- Surface slopes are small
- RMS roughness height  $< \lambda/2\pi$

## Very Rough Surfaces

- Tangent-plane approximation
- Roughness is isotropic
- Surface curvature  $\ll 1$
- Correlation length  $\ll$  Sample Length
- No multiple scattering
- No shadowing

# Surface/Volume Coupling

Modification of Adding/Doubling for Coupling Surface ( $R_s$ ) and Volume ( $R_p$ ) Scattering

$$S = R_s * R_p [I - R_s * R_p]^{-1}$$

$$D = [I + S] T_s$$

$$U = R_p D$$

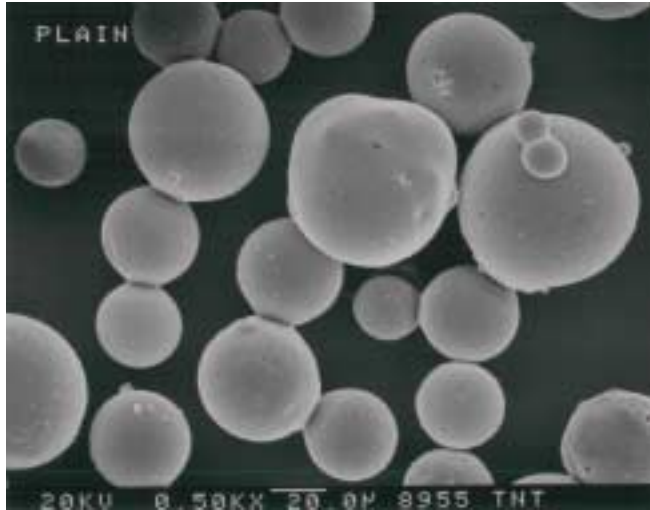
$$R = R_p + T_s * U' n_1^2 / n_2^2$$

$$T = T_s * D$$

Where

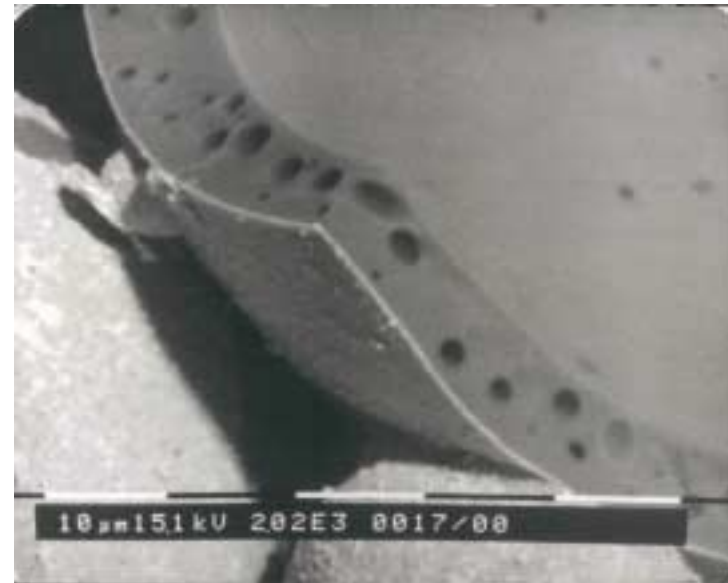
$$\begin{aligned} X * Y &= \int_0^l \left[ x_c(\mu) \frac{\delta(\mu - \mu')}{2\mu} + x^m(\mu, \mu') \right] \left[ y_c(\mu') \frac{\delta(\mu' - \mu_o)}{2\mu'} + y^m(\mu', \mu_o) \right] 2\mu' d\mu' \\ &= x_c(\mu) y_c(\mu) \frac{\delta(\mu - \mu_o)}{2\mu} + x_c(\mu) y^m(\mu, \mu_o) + y_c(\mu_o) x^m(\mu, \mu_o) \\ &\quad + \int_0^l x^m(\mu, \mu') y^m(\mu', \mu_o) 2\mu' d\mu' \end{aligned}$$

# Model Versus Measurement

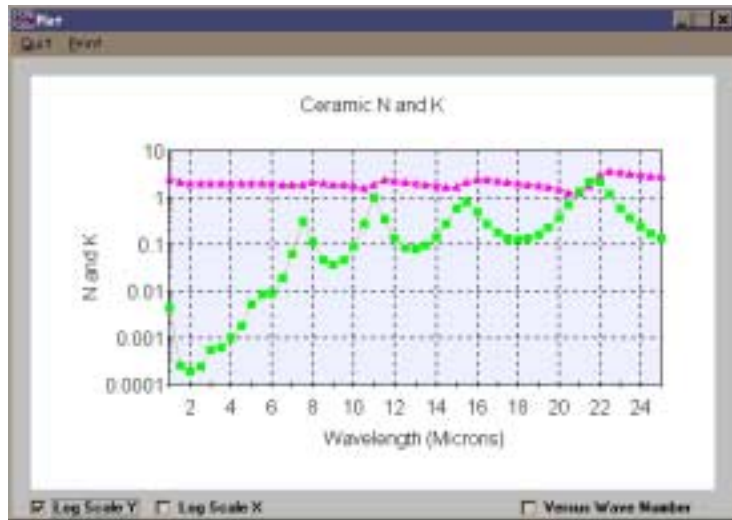


Pigment Modeled as Air Core  
and 2 Micron Ceramic Layer  
Alkyd Binder  
Surface Roughness  
Commensurate With Pigment  
Dimensions

Ceramic (Fly-Ash) Pigment  
10 - 70 micron diameter  
Log-Normal Size distribution  
Mean Diameter 41 microns

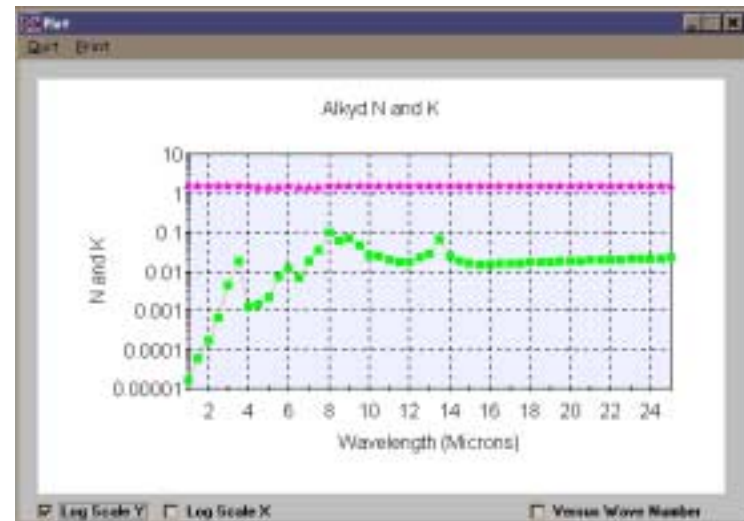


# Optical Constant Determination

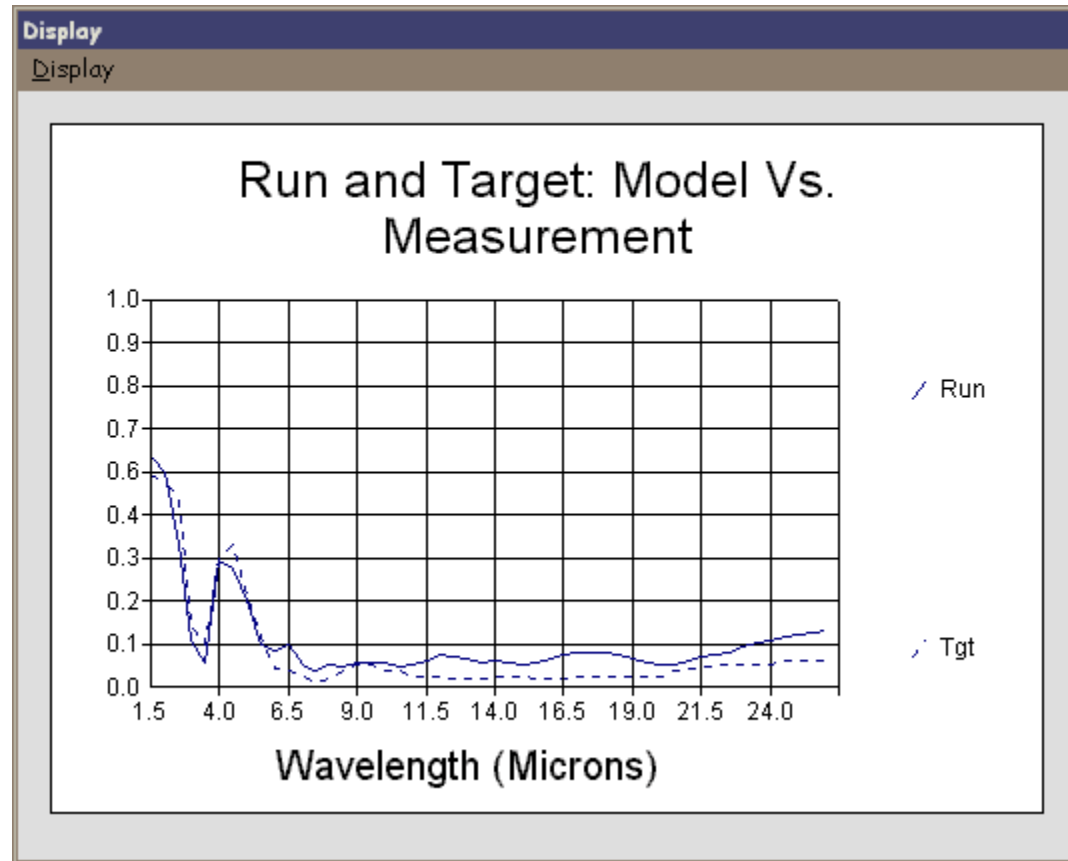


Ceramic Optical Constants  
Determined From Analysis  
of HDR Measurement of  
Micro-Balloon Powder

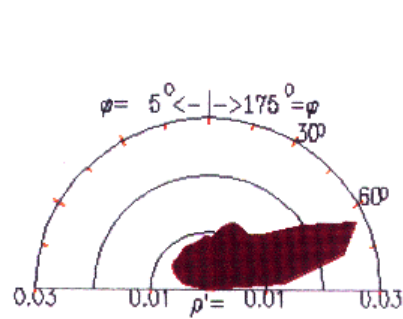
Alkyd Optical Constants  
Determined From Analysis  
of HDR Measurement of  
Thin Film Over Al Substrate



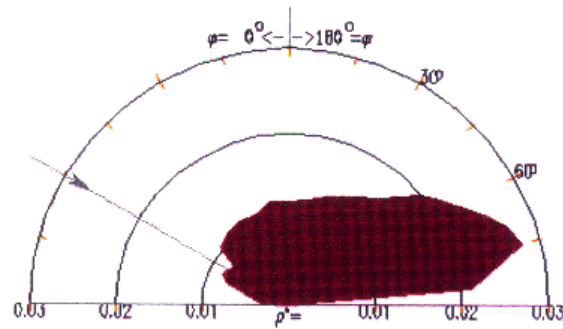
# HDR Model Versus Measurements



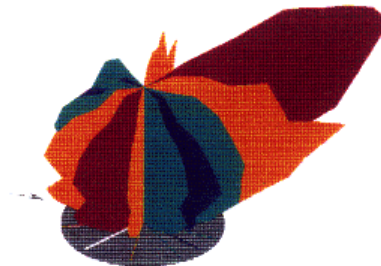
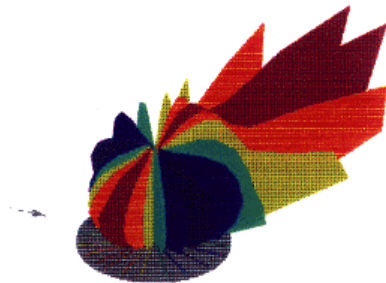
# BRDF Model Versus Measurements



**ScatCad  
Calculation**



**Measurement**





# Parameterized BRDF Models

- Parameterized BRDF Models used for Signature Simulations
- Specular/Diffuse Partition
  - Implemented in Graphics Accelerator Cards
- Sandford-Robertson Four-Parameter Model
  - Widely Used in Signature Codes (e.g., SPIRITS)
- OPTASM Lorentzian Lobe Model
  - Non-Specular BRDF Lobes, Mueller Matrix

# Sandford-Robertson Model

- Based on the Separation of the Spectral and Directional Dependence of the Total BRDF

$$\rho'(\theta_i, \phi_i; \theta_r, \phi_r; \lambda) = f_r(\theta_i, \phi_i; \theta_r, \phi_r) \rho(\lambda)$$

$$f_r(\theta_i, \phi_i; \theta_r, \phi_r) = f_S(\theta_i, \phi_i; \theta_r, \phi_r) + f_D(\theta_i, \phi_i; \theta_r, \phi_r)$$

- Fits Four Parameters to the BRDF

$\rho_D(\lambda)$  = Diffuse Spectral Reflectance

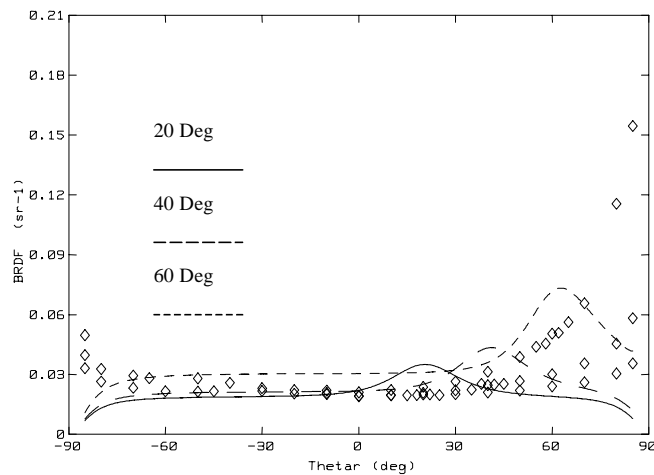
$\varepsilon(\lambda)$  = Spectral Emissivity

$b$  = Grazing Angle Reflectivity

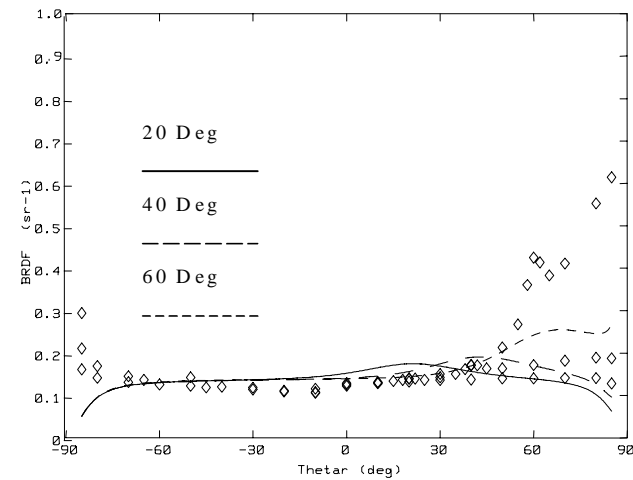
$e$  = Width of Specular Lobe

# S-R Model Fit to Green 383

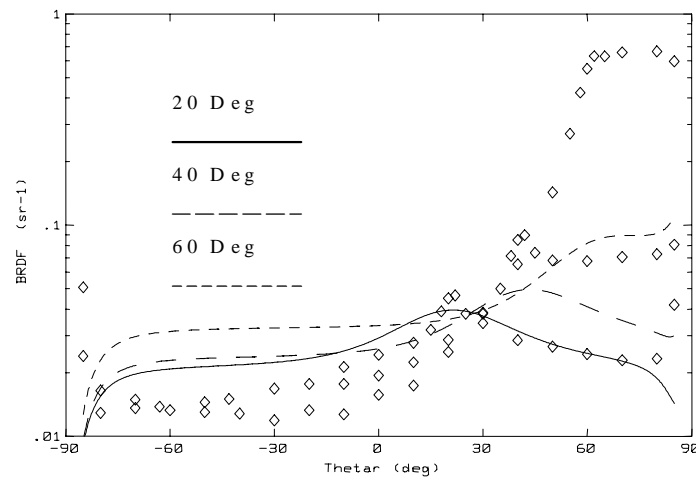
$\lambda = 0.54$  microns



$\lambda = 4.4$  microns



$\lambda = 10$  microns



# OPTASM BRDF Model

- Angular Scattering Represented by Lorentzian Shaped Peaks

$\rho_o$  = Constant Term

$A$  = Peak Strength

$B$  = Lobe Width in Degrees

$\Gamma$  = Angle Between Peak Direction,  $\hat{k}_p$ ,  
and Viewed Direction,  $\hat{k}_r$ .

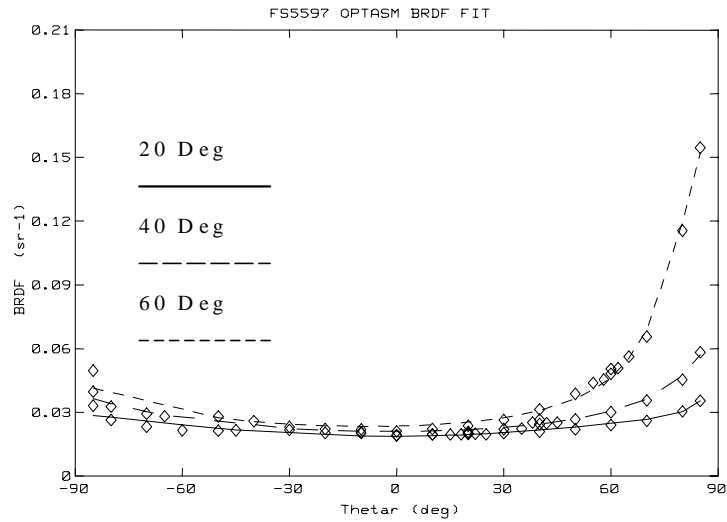
$$\rho'(\hat{k}_i, \hat{k}_r) = \rho_o + A_1 / \{B_1^2 + 1 - \cos \Gamma_1\} + A_2 / \{B_2^2 + 1 - \cos \Gamma_2\}$$

$$\Gamma = \cos^{-1}(\hat{k}_p \cdot \hat{k}_r)$$

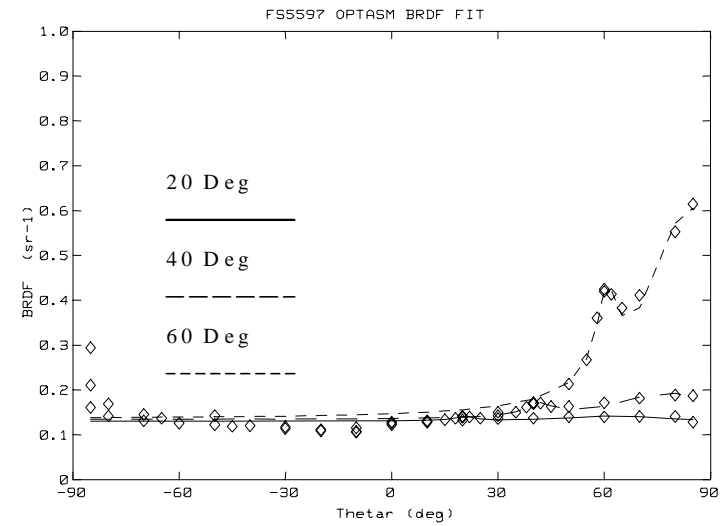
- 2nd Term Represents Diffuse Scattering, 3rd Term Used for Specular Lobe (Nominally Seven Parameter Model)
- Additional Terms May Be Added for Non-Isotropic and Backscattering Features

# OPTASM Model Fit to Green 383

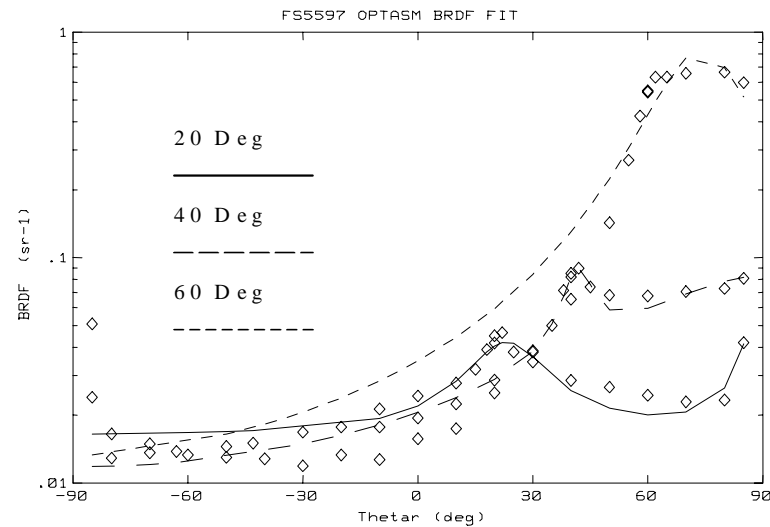
$\lambda = 0.54$  microns



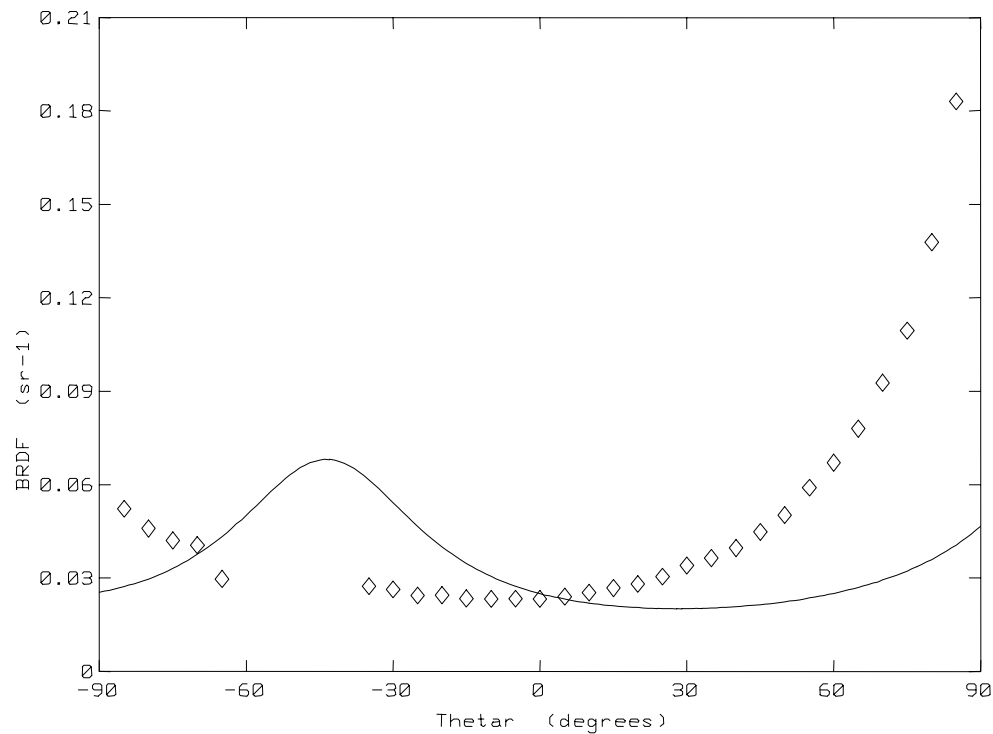
$\lambda = 4.4$  microns



$\lambda = 10$  microns



# OPTASM BRDF Model Prediction Versus Measurement at 50 Degrees



$\lambda$	Fit Param	$\theta_i$		
		20	40	60
0.54	$\rho_o$	0.224	0.0	0.0
	$\theta_{p1}$	83.2	105.7	185.1
	$A_1$	4.74e-5	6.81e-3	7.85e-2
	$B_1$	2.06e-2	5.74e-0	1.3e+1
	$\theta_{p2}$	-2.0	-175.6	88.5
	$A_2$	-6.6e-1	7.38e-2	1.61e-2
	$B_2$	-2.4e+2	2.5e+2	8.87e-0
4.44	$\rho_o$	0.130	0.133	0.132
	$\theta_{p1}$	21.0	41.7	60.7
	$A_1$	5.50e-4	2.35e-3	6.42e-3
	$B_1$	2.4e+0	3.48e-0	2.56e-0
	$\theta_{p2}$	62.6	77.3	84.0
	$A_2$	3.89e-3	1.56e-2	7.67e-2
	$B_2$	1.1e+1	1.2e+1	9.57e-0
10.0	$\rho_o$	0.016	0.0	0.0
	$\theta_{p1}$	23.2	41.8	73.8
	$A_1$	1.02e-2	3.85e-3	1.94e-1
	$B_1$	8.8e+0	3.30e-0	1.0e+1
	$\theta_{p2}$	92.6	92.3	85.0
	$A_2$	1.21e-3	7.57e-2	9.94e-5
	$B_2$	1.3e+0	3.3e+1	1.0e+1

# Conclusions

- Complex BRDF Phenomenology is a Significant Feature for Visible/IR Signature Simulations
- Optical Measurements and Phenomenological Models Can Provide Qualitative/Quantitative Insight Into the Optical Properties of Coatings and Surfaces
- ScatCad is a Phenomenological Model for Engineering BRDF and HDR Analysis of Pigmented Coatings
- Use of Parameterized BRDF Models Depends on the Quality of the Fit and the Ability of the Parameters to be Interpolated/Extrapolated to Other Angles